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# Electrochemical impedance spectroscopy (EIS) and half-cell potential measurements as tools for degradation analysis and AST development within PEM water electrolysis test cells

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Thomas Lickert, Claudia Schwarz,  
Arne Fallisch, Anatolij Friske, Tom  
Smolinka

Fraunhofer Institute for Solar  
Energy Systems ISE

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[www.ise.fraunhofer.de](http://www.ise.fraunhofer.de)

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# Outline

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- Motivation
- Development of AST protocols
- Test equipment at Fraunhofer ISE
- In-situ characterization method development
- Conclusion

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# Motivation

## Why do we need ASTs?

- PEM electrolysis cells are electrochemically stable, degradation occurs slowly
  - Investigation of the degradation on materials is cost intensive
- Cheaper and more efficient stacks are required in the future
- New materials are needed, where degradation behaviour is unknown
  - Fast screening of these materials and profiles necessary

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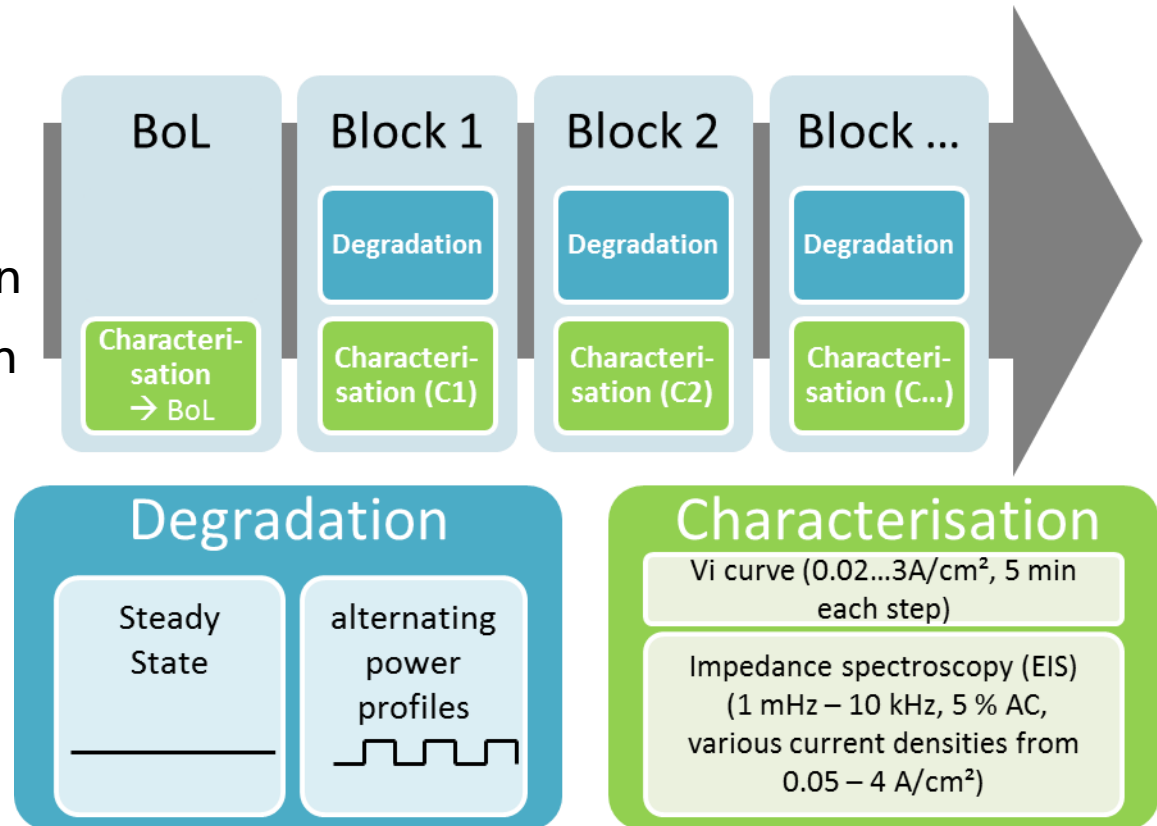
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# Development of AST protocols

## Our Approach for characterization

### ■ Operating conditions:

- Current density
- Temperature
- H<sub>2</sub>O contamination
- Dynamic operation
- Pressure

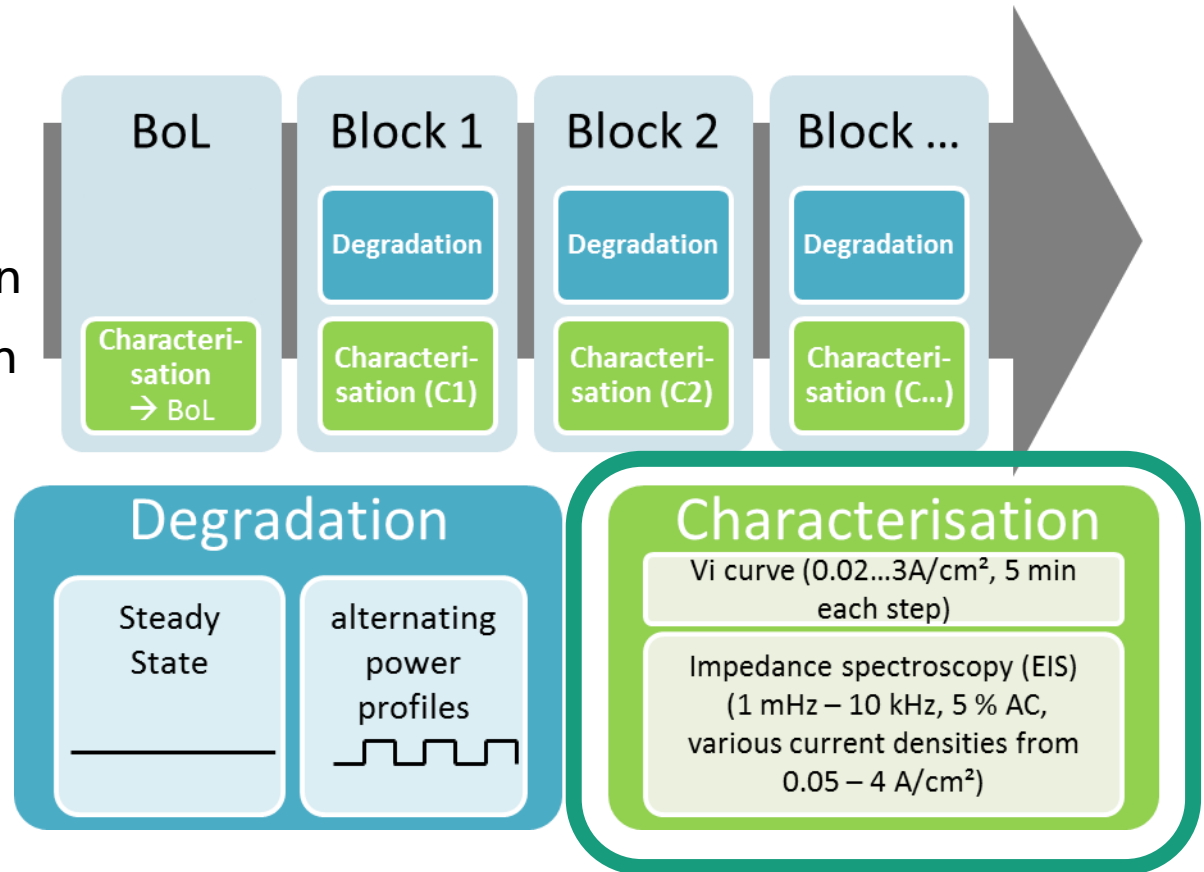


# Development of AST protocols

## Our Approach for characterization

### ■ Operating conditions:

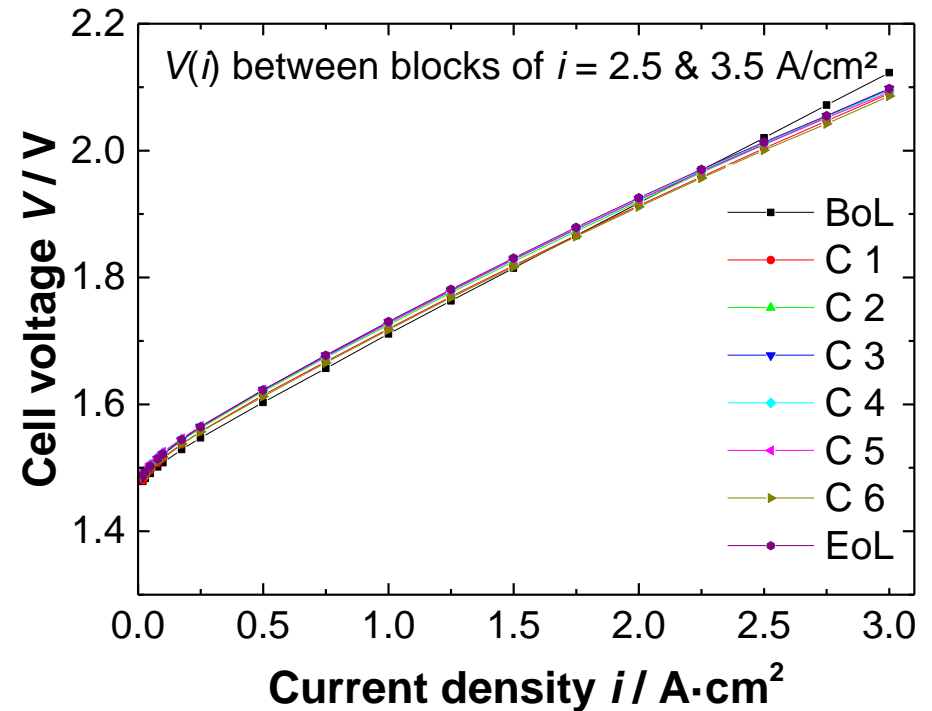
- Current density
- Temperature
- H<sub>2</sub>O contamination
- Dynamic operation
- Pressure



# Development of AST protocols

## Why do we need in-situ characterization methods?

- $V_i(t)$  changes are rather small (within  $\approx 340$  h)
- Information content in  $V_i$  is limited

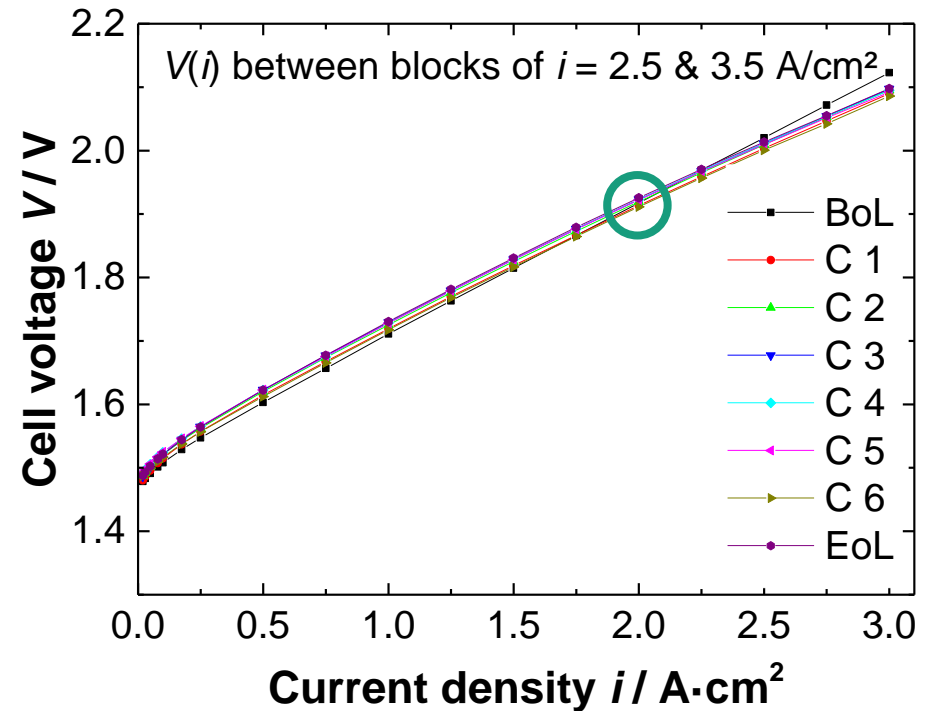




# Development of AST protocols

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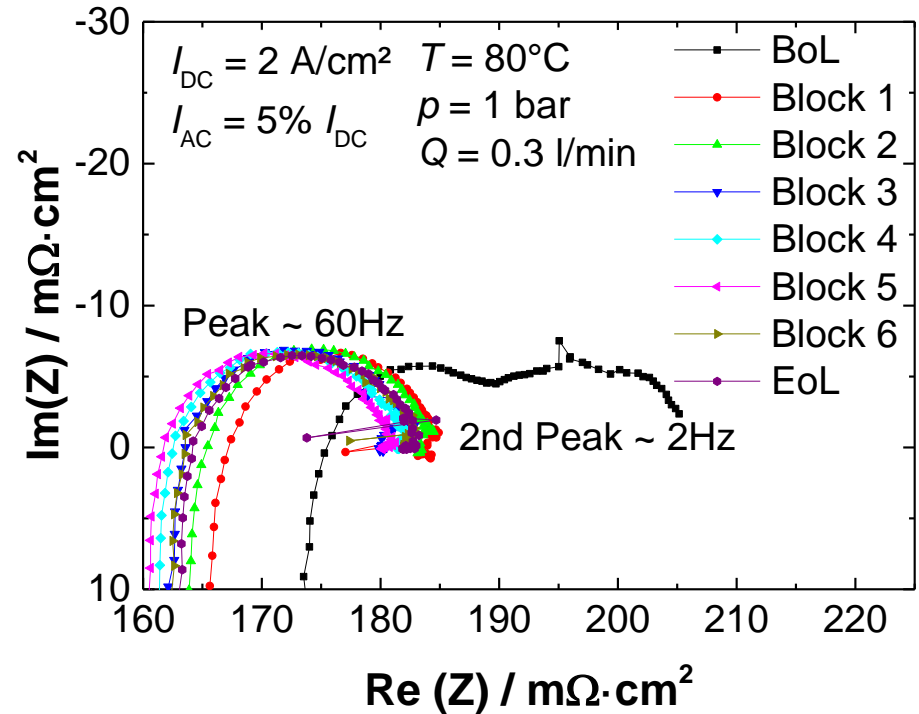


# Development of AST protocols

## Why do we need in-situ characterization methods?

- $V_i(t)$  changes are rather small (within  $\approx 340$  h)
- Information content in  $V_i$  is limited
- Information content in EIS more comprehensive

→ Further characterization method development is very important



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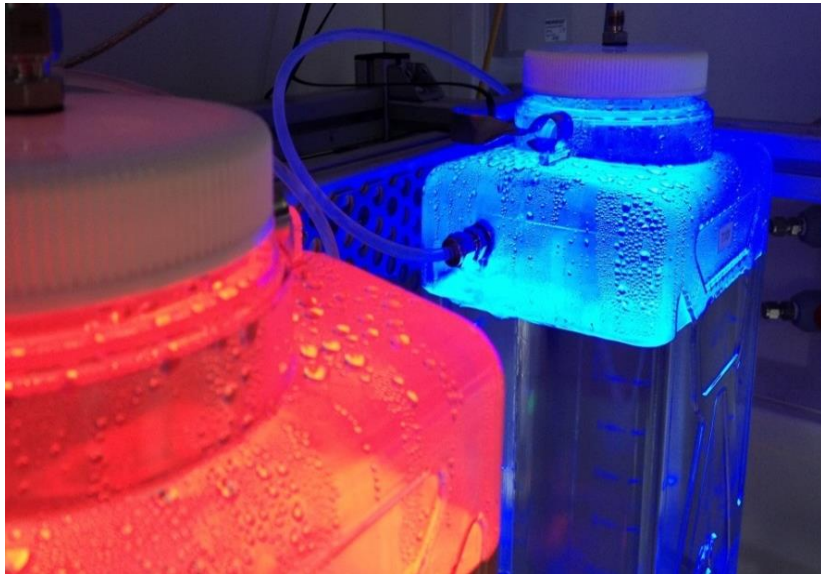
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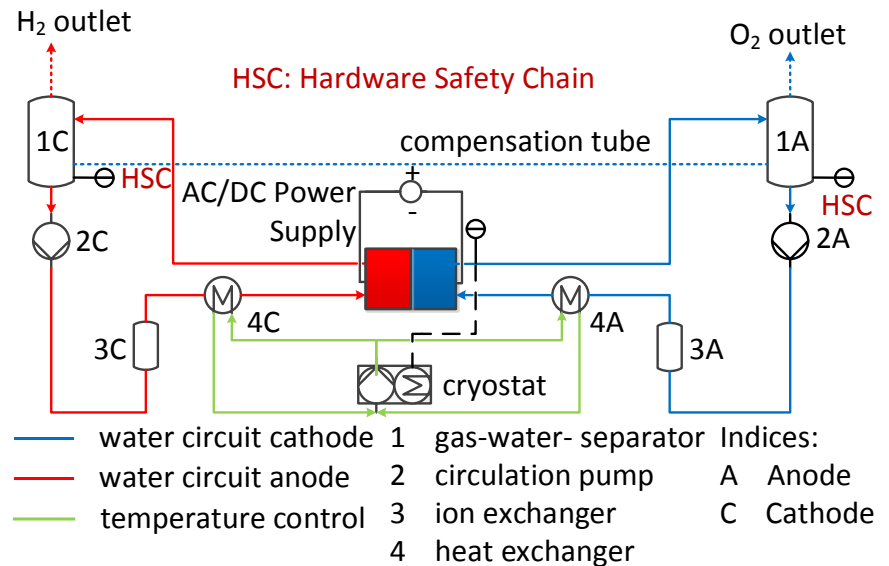
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# Test equipment at Fraunhofer ISE

## Non-automated, unpressurized test bench



- Operation temperature up to 80°C
- Ivium 4 channel potentiostat + 100 A Ivium booster

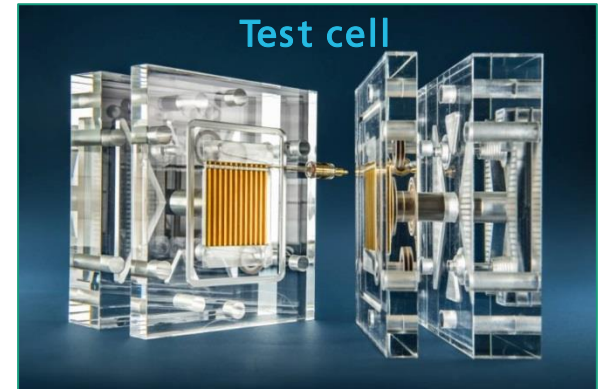


- Impedance spectroscopy
  - up to  $i_{DC} = 4 \text{ A/cm}^2$  (25 cm<sup>2</sup>)
  - $f = 0.1 \text{ Hz} - 10 \text{ kHz}$

# Test equipment at Fraunhofer ISE

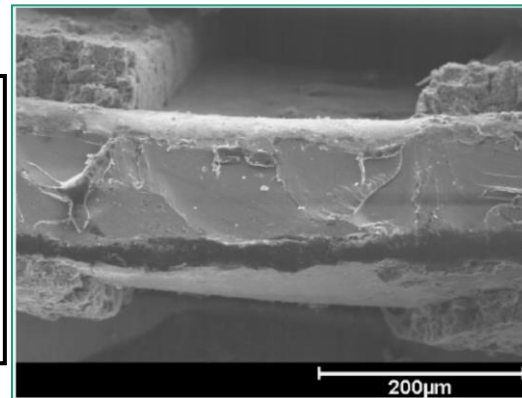
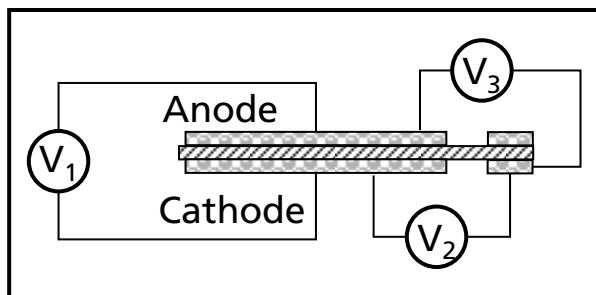
## Cell setup with in-situ overpotential measurement

- Investigation of anodic and cathodic overpotentials
- Reference electrode made by laser ablation
- Pressurized measurements up to 50 bar
- Cell area of 25 cm<sup>2</sup> (including reference electrode)



Cross-section of a laser ablated CCM

Test bench



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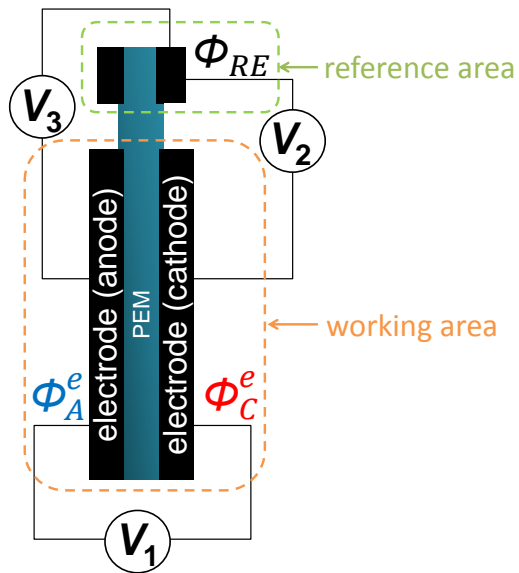
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# In-situ characterization method development

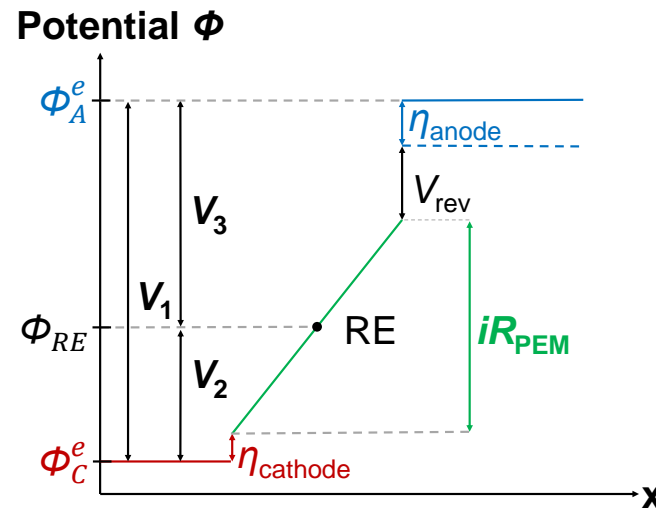
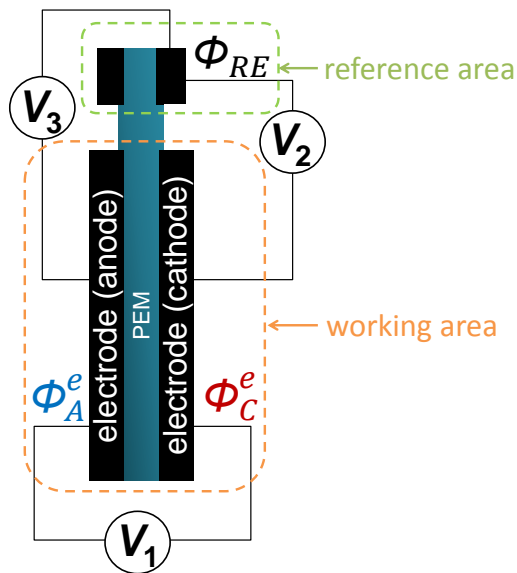
## Reference Electrode (RE)



# In-situ characterization method development

## Reference Electrode (RE)

- Assumption that potential in the middle of the membrane is measured

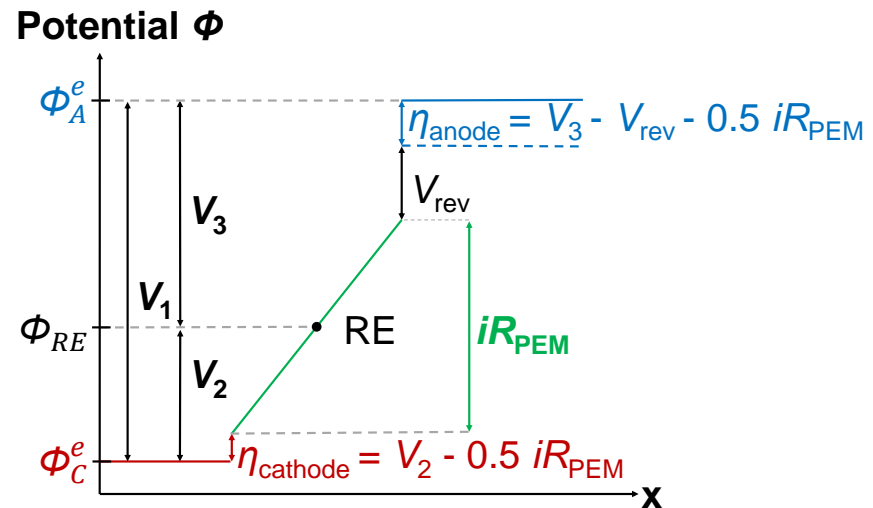
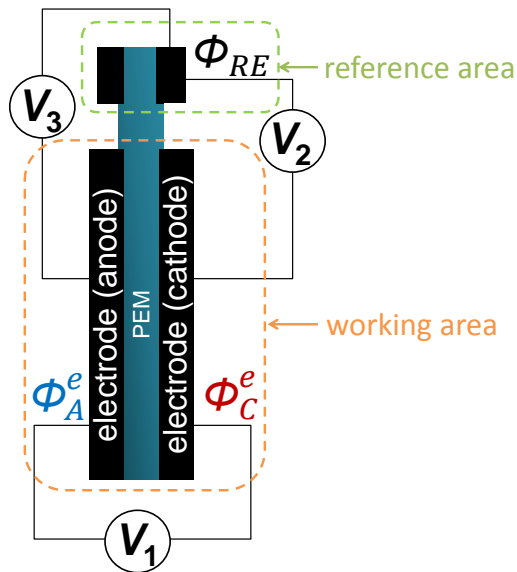




# In-situ characterization method development

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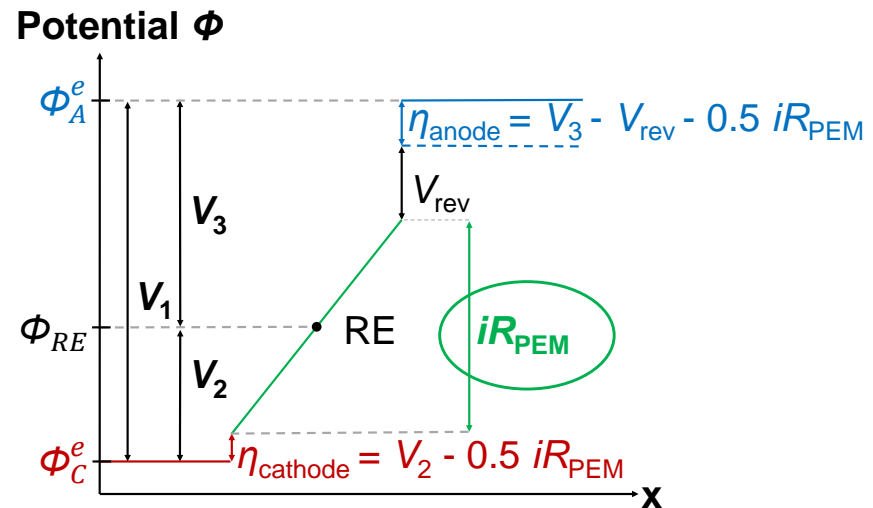
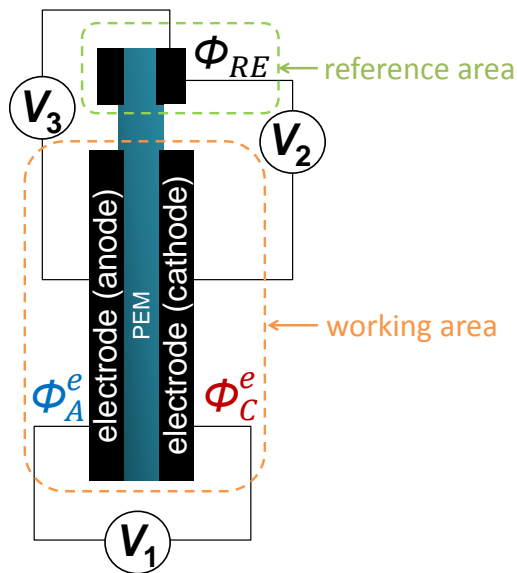
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# In-situ characterization method development

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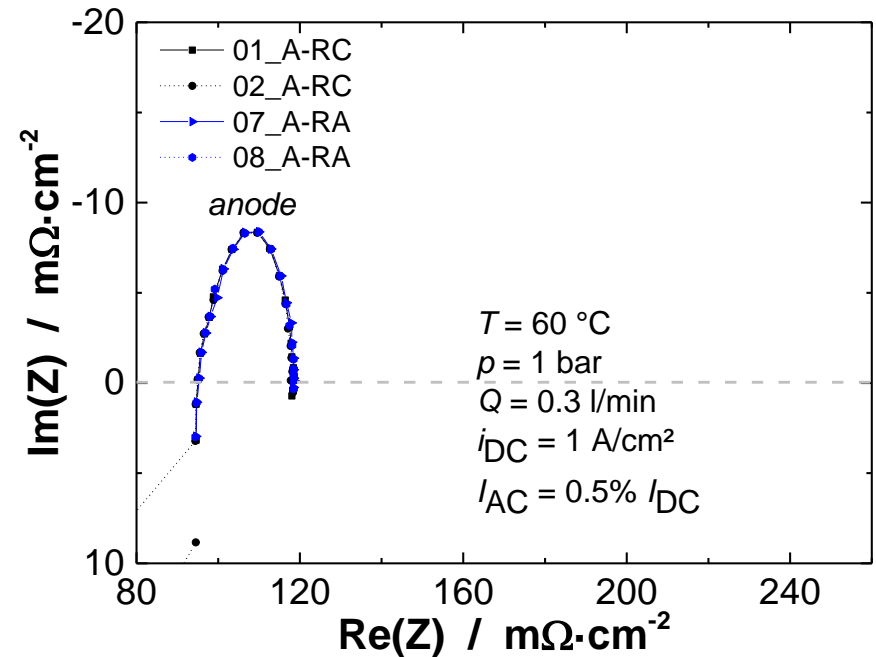




# In-situ characterization method development

## Reference Electrode (RE) – half cell spectra

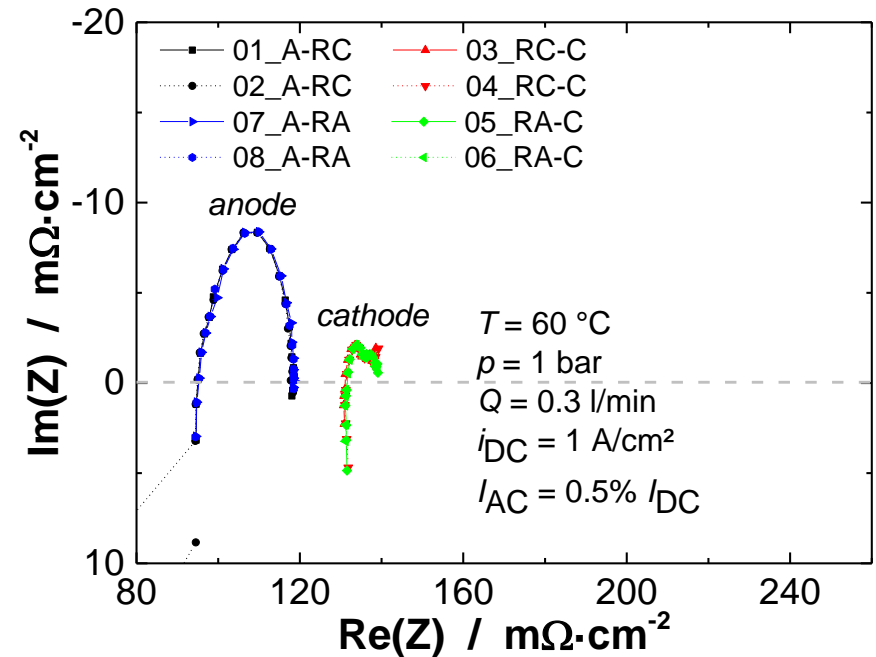
- Half-cell spectra as tool to determine location of RE-potential



# In-situ characterization method development

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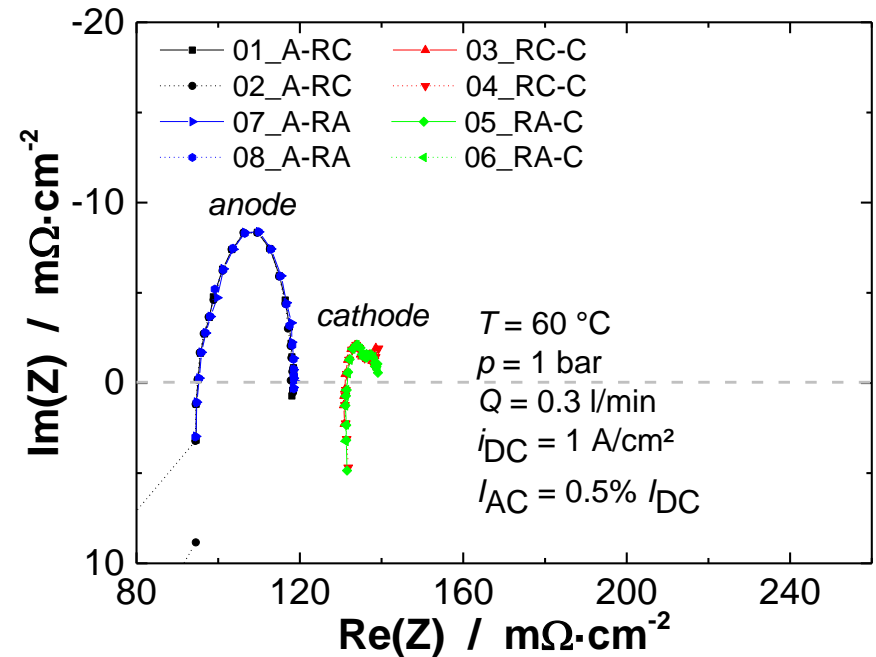
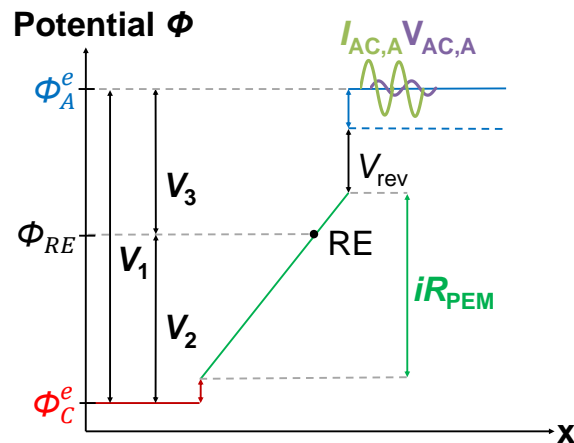
- Half-cell spectra as tool to determine location of RE-potential
- Cathode limitation is not neglectable



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## Reference Electrode (RE) – half cell spectra

- Half-cell spectra as tool to determine location of RE-potential
- Cathode limitation is not neglectable
- RE potential is shifted away from the middle towards the anode



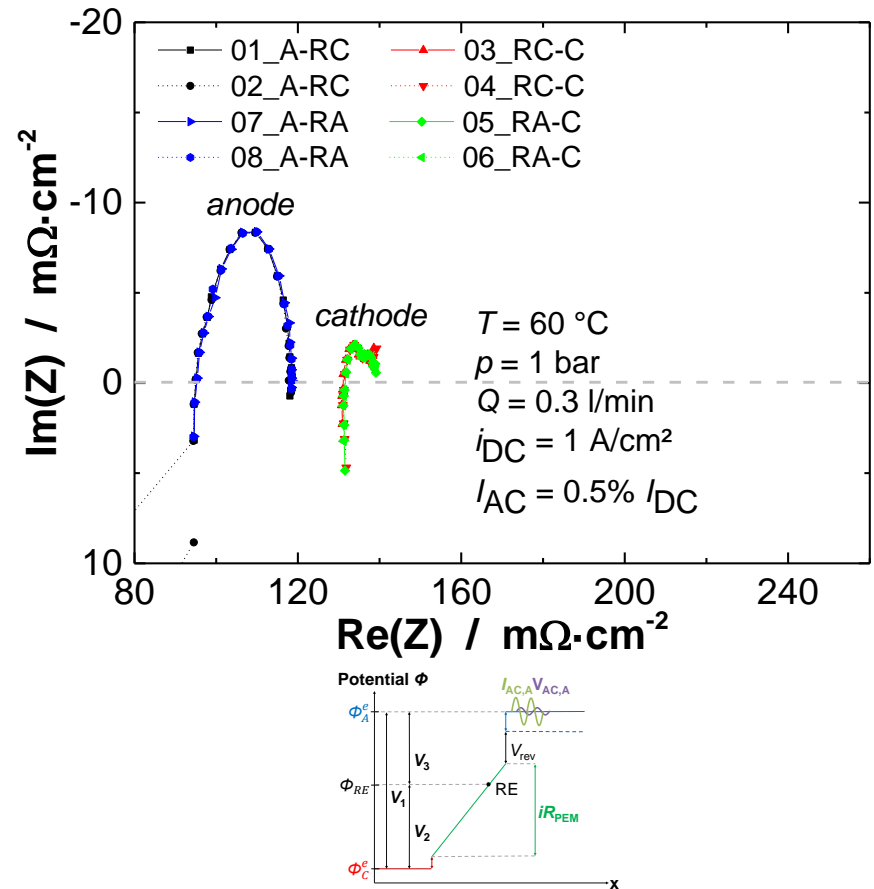
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## Reference Electrode (RE) – half cell spectra

- Half-cell spectra as tool to determine location of RE-potential
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- Factor in calculation of overpotential which is not 1/2

$$f(?) \downarrow$$

$$\eta_A = V_3 - \frac{1}{2} i_{\text{cell}} Z_1^* - V_{\text{rev}}$$



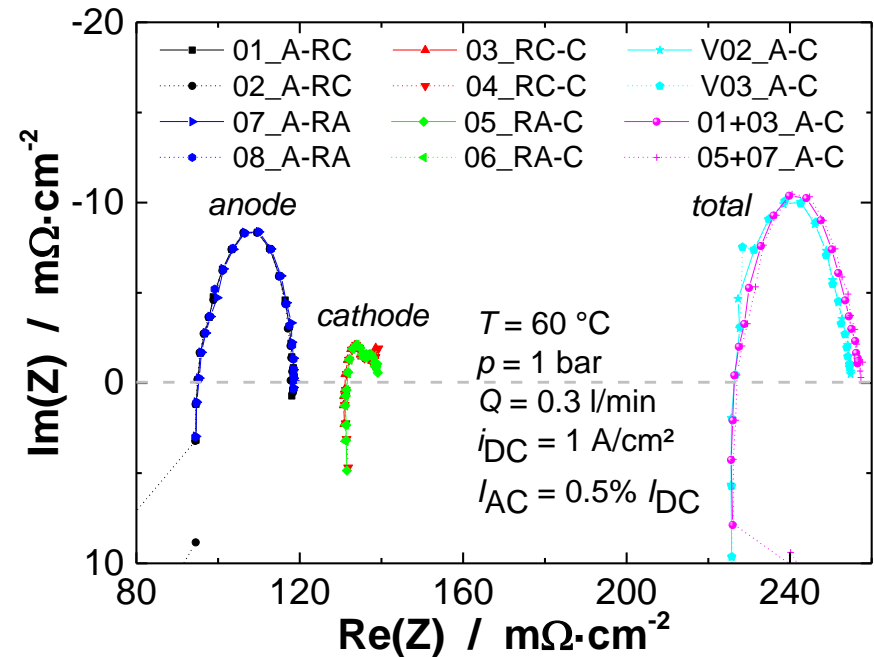
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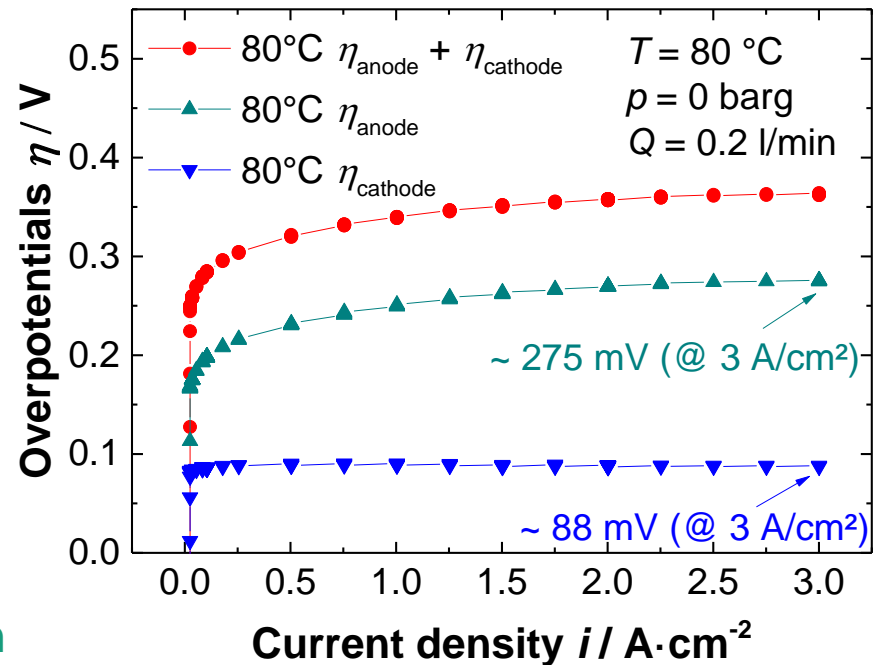




# In-situ characterization method development

## Reference Electrode (RE) – PEM behavior → AST

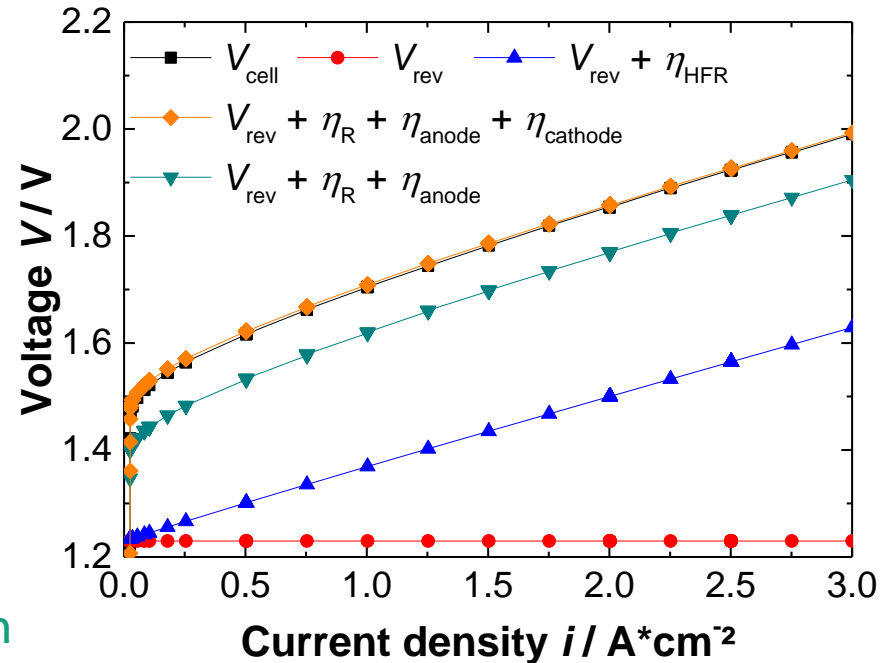
- Half-cell spectra as tool to determine location of RE-potential
  - Separate examination of anodic and cathodic overvoltages
    - Separate degradation analysis
  - E.g.: overpotentials @ 3 A/cm<sup>2</sup>
    - Anode ≈ 275 mV
    - Cathode ≈ 88 mV
- Separate anode and cathode in AST development



# In-situ characterization method development

## Reference Electrode (RE) – PEM behavior → AST

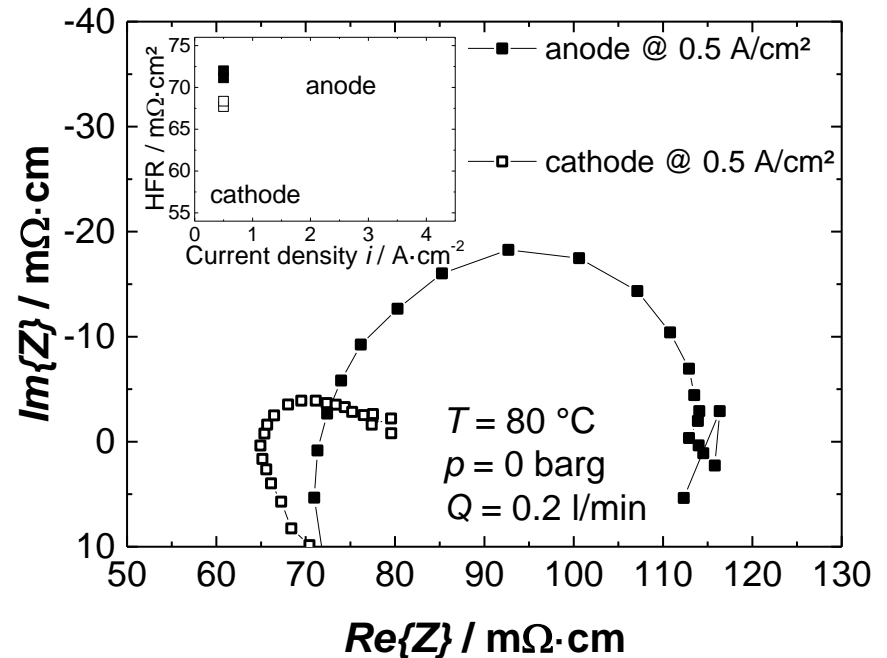
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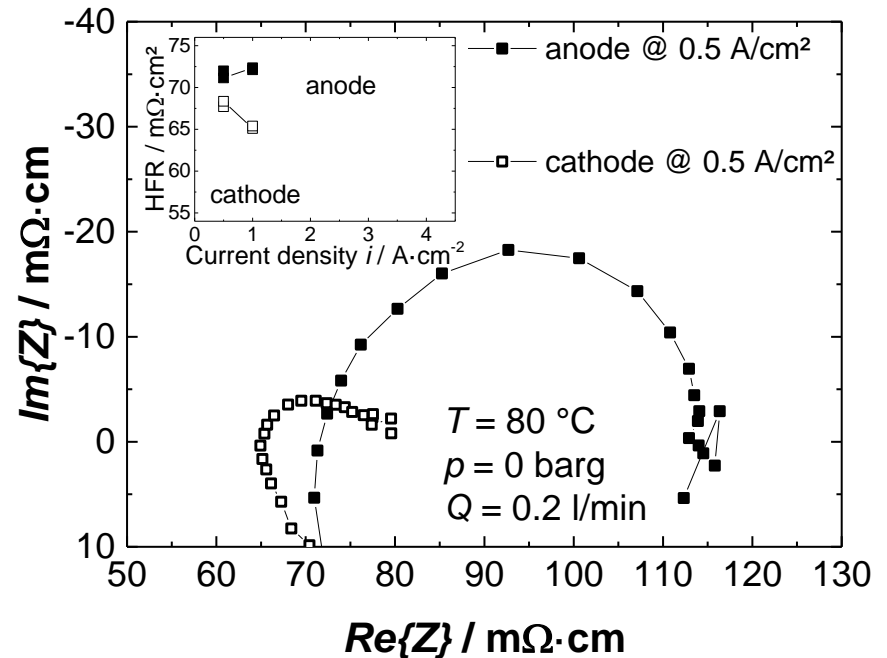
- Half impedance spectra to extract HFR of anode and cathode



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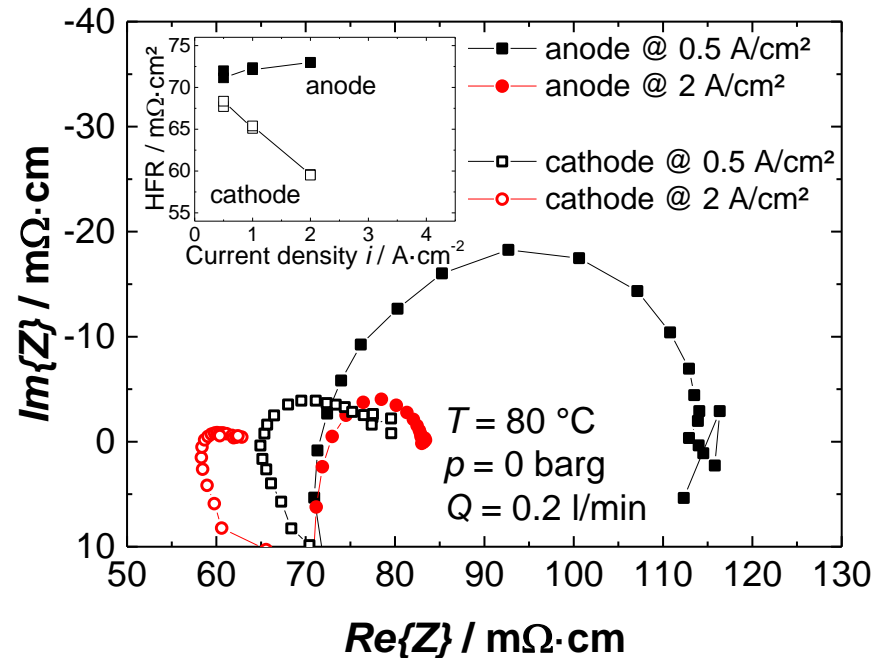
- Half impedance spectra to extract HFR of anode and cathode
- HFR is current dependant



# In-situ characterization method development

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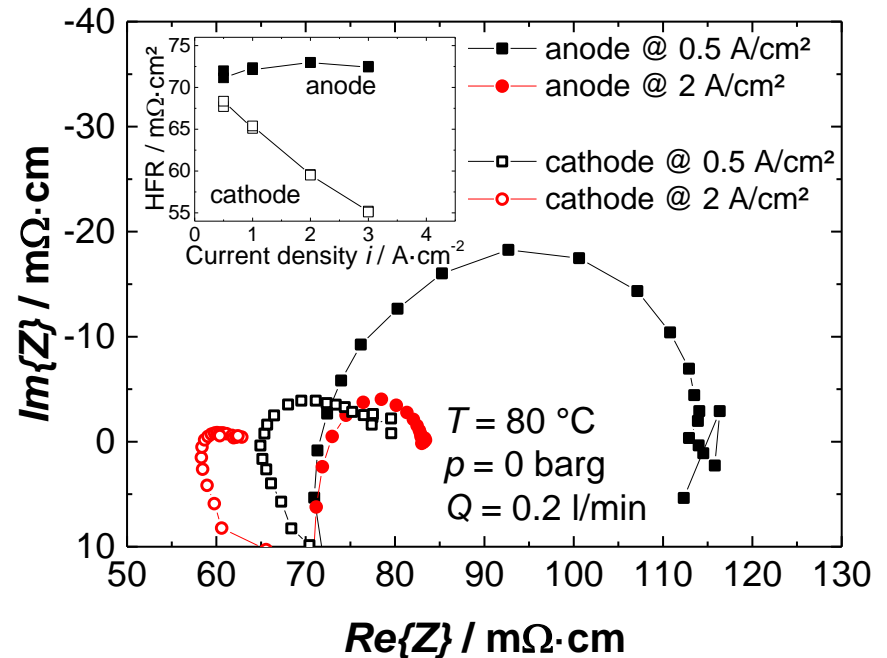
- Half impedance spectra to extract HFR of anode and cathode
- HFR is current dependant
- Cathode HFR decreases



# In-situ characterization method development

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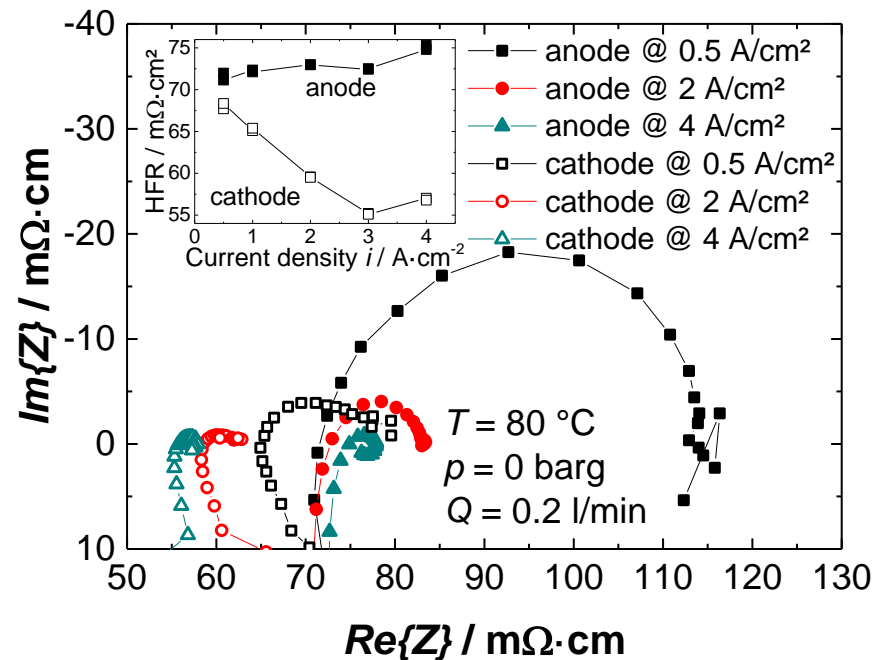
# In-situ characterization method development

## Reference Electrode (RE) – PEM behavior → AST

- Half impedance spectra to extract HFR of anode and cathode
- HFR is current dependant
- Cathode HFR decreases
- Anode HFR slightly increases
- Factor to calculate overvoltages is dependent on current

$$f_{RE}(i) \downarrow$$

$$\eta_A = V_3 - \frac{1}{2} i_{\text{cell}} Z_1^* - V_{\text{rev}}$$



# In-situ characterization method development

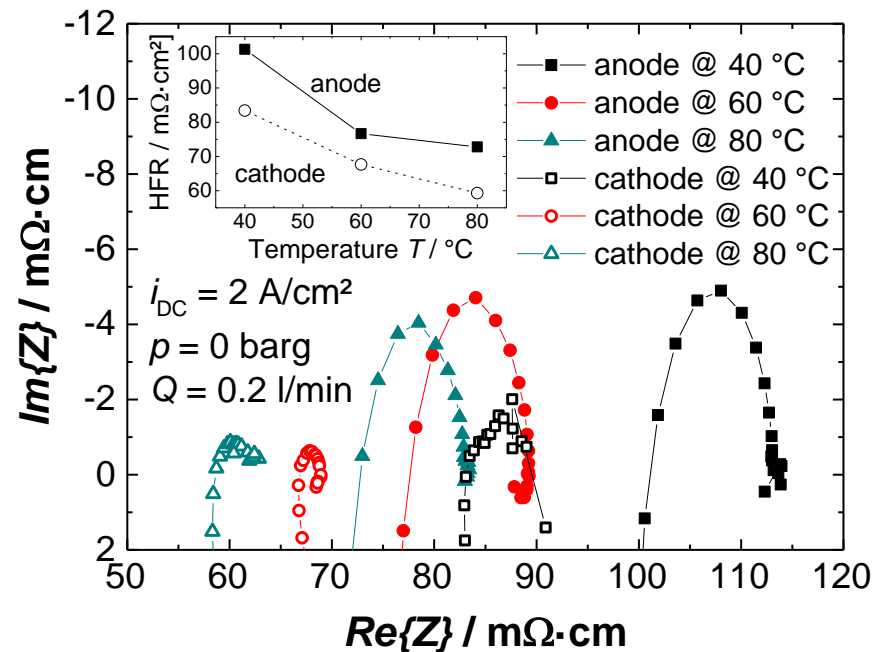
## Reference Electrode (RE) – PEM behavior → AST

- Half impedance spectra to extract HFR of anode and cathode
- HFR is temperature dependant
- Cathode and anode HFR decreases
- Factor to calculate overvoltages is also dependent on temperature

$$f_{RE}(i, T)$$

↓

$$\eta_A = V_3 - \frac{1}{2} i_{cell} Z_1^* - V_{rev}$$





# In-situ characterization method development

## Reference Electrode (RE) – PEM behavior → AST

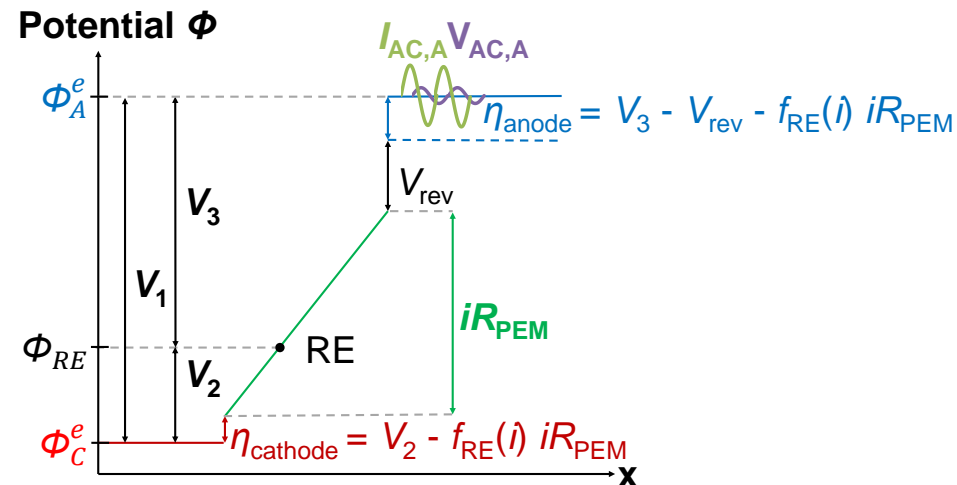
- Reduction of  $HFR$  with increasing  $I$  and  $T$  coming mainly from cathodic side

- Heat production on anodic side might influence PEM behavior

- Possible gradient in  $T$  inside the PEM individual  $HFR$  shifts?

- Possible gradient in water content ( $\lambda$ ) inside the PEM?

→ AST development for PEM possible



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# Outline

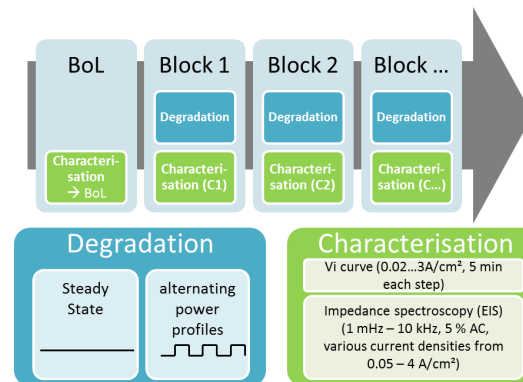
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# Conclusion

## Summary

- Comprehensive understanding of in-situ characterization methods is necessary for AST development
  - RE-method for local separation of degradation effects
  - EIS for separation of transient behavior of degradation effects
  - Half-cell EIS for more insight and verification of both methods
- Evaluation of different operating profiles and their influence on degradation can be investigated more substantially
- Let's test different profiles



# Acknowledgements



- All members of the departments “Chemical Energy Storage” at Fraunhofer ISE

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  - Project “POWER-MEE” - contract n° 03SF0536D

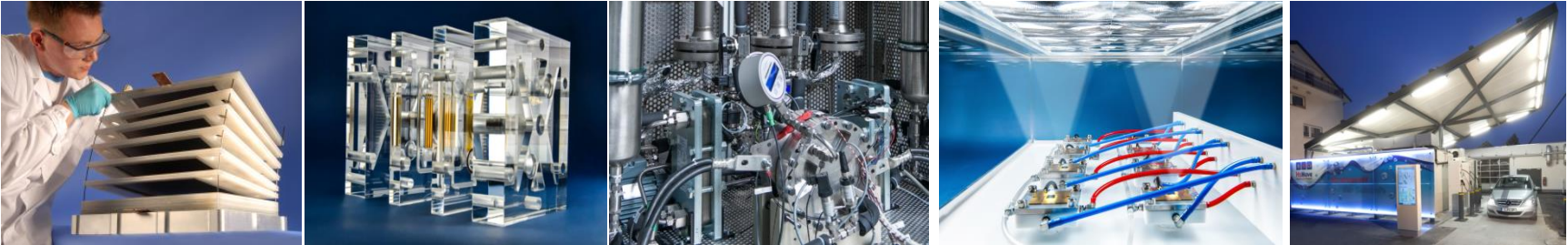
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Arne Fallisch

[www.ise.fraunhofer.de](http://www.ise.fraunhofer.de)

[arne.fallisch@ise.fraunhofer.de](mailto:arne.fallisch@ise.fraunhofer.de)